

Energy calibration of GaAs:Cr-based Timepix detector with alpha particles

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Abstract

The advanced GaAs:Cr material for radiation detection is in the scope of many scientific and technological institutions in the world, as a result of its proved superior properties and economic advantages. The energy calibration of a hybrid GaAs:Cr-based Timepix detector with alpha particles performed in the Dzhelepov Laboratory of Nuclear Problems at Joint Institute for Nuclear Research confirms that the device is able to register these particles in energy range from 3140 to 7687 keV. The mathematical simulation was used to calculate the transmitted energy, making possible the experimental calibration with the use of Mylar as absorbent. By calibrating the detector with characteristic X rays of some target materials and using a two steps fitting procedure was determined the relationship between the photon energies and the registered by the detector TOT counts. The energy calibration with alpha particles was performed according to a linear function and verified with the measurement of the ^{218}Po line of radon in air.

Key words: Cuba; mathematical models; JINR; international cooperation; experimental data; calibration.

Calibración energética de un detector Timepix basado en GaAs:Cr con partículas alfa

Resumen

El GaAs:Cr como material de avanzada para la detección de las radiaciones se encuentra en la mira de muchas instituciones científicas y tecnológicas en el mundo, como consecuencia de sus superiores propiedades y ventajas económicas. Los experimentos hechos en el Laboratorio de Problemas Nucleares Dzhelepov del Instituto Unificado de Investigaciones Nucleares para la calibración energética de un detector híbrido Timepix basado en GaAs:Cr con partículas alfa confirma que este dispositivo es capaz de registrar partículas en el rango energético de 3410 a 7687 keV. Se utilizó la simulación matemática para calcular la energía transmitida, haciendo posible la calibración experimental con el uso de Mylar como absorbente. Utilizando la calibración del detector hecha con los rayos X característicos de algunos materiales blanco y empleando un procedimiento de ajuste en dos pasos fue determinada la relación entre la energía de los fotones y los conteos TOT registrados por el detector. Se realizó la calibración energética con partículas alfa de acuerdo con una función lineal y se verificó con la medición de la línea del ^{218}Po del radón en aire.

Palabras clave: Cuba; modelos matemáticos; JINR; cooperación internacional; datos experimentales; calibración.

Introduction

In recent years hybrid pixel detectors have shown great impact in many fields of human activity as well as experimental physics, biology, geology, medicine and imaging technology. In high energy physics these detectors are used for the registration of particles, and especially in tracking and timing application.

The Dzhelepov Laboratory of Nuclear Problems of the Joint Institute for Nuclear Researcher (JINR), in coo-

peration with other institutions such as Medipix international collaboration (CERN), the Institute of Experimental and Applied Physics of the Czech Technical University (Prague) and the Tomsk State University, investigates the convenience of using the GaAs:Cr as integrated sensor in hybrid pixel detectors based on the Timepix readout chip [1]. GaAs:Cr is a very promising material for the development of sensors for applications ranging from medical imaging to high energy physics due to its numerous advantages over others semiconductors [2-4].

Some of those are the possible operation at room temperature, the high resistivity to radiation damage and the high attenuation coefficient.

Several investigations about response of GaAs:Cr-based detectors to X and gamma rays have been carried out, but today the behavior of these detectors to heavy charged particles, such as alpha particles or ions is still a little studied subject.

The main objective of this work is to perform the energy calibration of a Timepix detector based on GaAs:Cr sensor with alpha particles. For this purpose, ^{241}Am and ^{226}Ra sources and mathematical simulation were used.

Materials and methods

The used detector was a Timepix device with 900 μm GaAs:Cr sensor grown by the Czochralski Liquid Encapsulation method [5] and subsequently compensated with Cr by thermal diffusion [6]. The cathode is formed by 1 μm Ni layer, whereas anode is structured in matrix of 256 x 256 pixels, each of which has dimensions of 45 x 45 μm^2 and a distance between them of 10 μm . Each anode has a layer structure of Au/Ni/Cu/V type and regions between them are occupied by silicon oxide as an insulator and protection (figure 2.1 a and b).

A shielded experimental station was used for characteristic X-ray spectra measurement of different target. This workstation is equipped with a copper coated tungsten anode microfocus X-ray tube SB120 [7] employed as primary radiation source. Using a set of known materials and a reflection geometry with respect to primary X-ray beam (figure 2.1c), it is possible to obtain photon energies in a range between 7 and 57 keV as result of target fluorescence.

Table 1 shows a list of target materials employed in the experiment to obtain different X-ray energies. Only $K_{\alpha 1}$ lines were used in our case.

Table 1. Target materials and results of the Gaussian fitting for each photon energy.

Target material	Photon energy (keV)	TOT [DAC] mean value	Sigma
^{28}Ni	7.48	23.34	7.265
^{29}Cu	8.04	24.79	7.374
^{30}Zn	8.64	26.37	8.162
^{40}Zr	15.78	47.18	9.52
^{42}Mo	17.48	52.68	9.299
^{45}Rh	20.22	61.03	8.881
^{48}Cd	23.17	68.88	9.18
^{49}In	24.2	71.48	9.691
^{50}Sn	25.27	74.55	9.517
^{73}Ta	57.54	150.8	21.29

For measurements with alpha particles was used a vacuum chamber containing a support for radioactive source and detector alignment and a vacuum pump, high voltage source for detector bias and PC for data acquisition.

The experimental idea (see schema in figure 2.1 d) was to pass alpha particles from radioactive source through different thicknesses of Mylar films located between source and detector, in order to obtain an energy range for perform the corresponding calibration. ^{241}Am and ^{226}Ra were used as radiation sources, and Mylar film thicknesses were obtained from combinations of 3 μm

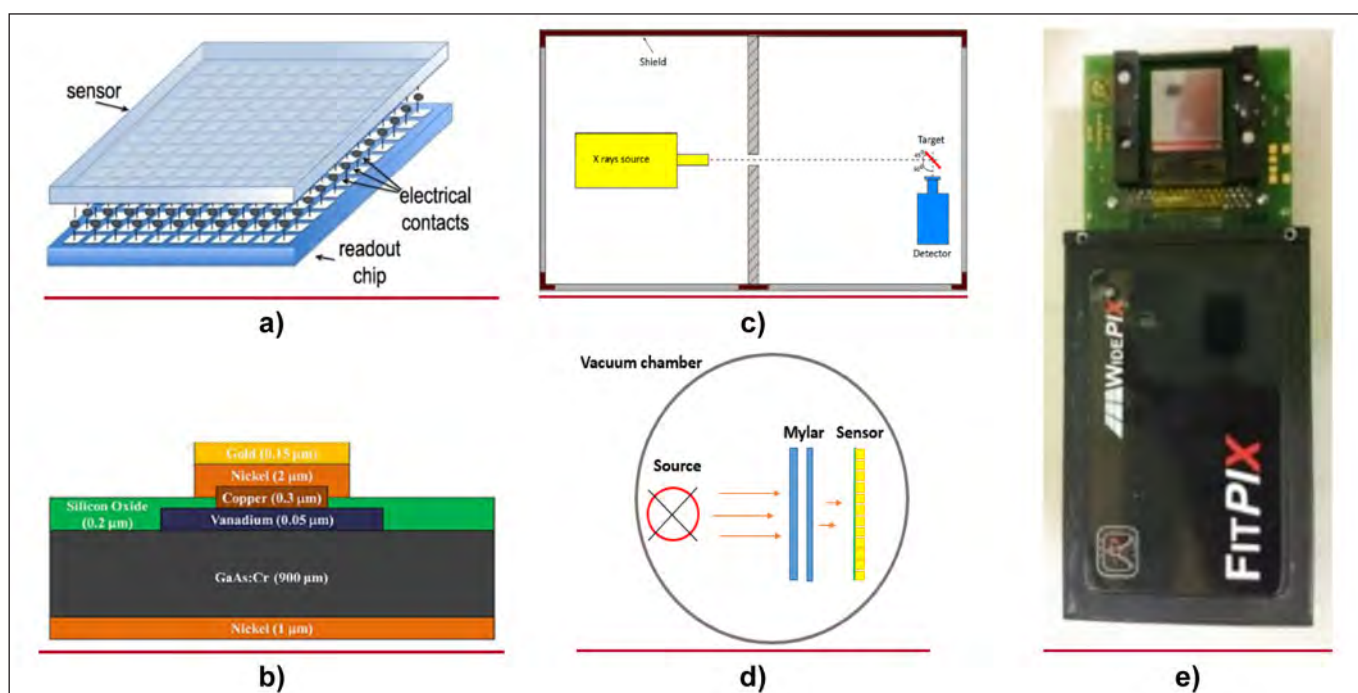


Figure 2.1. a) General scheme of the hybrid detector; b) graphical representation of the single pixel basic structure; c) schematic representation of reflection geometry used for characteristic X-rays measurements; d) schematic representation of the experimental configuration inside of the vacuum chamber; e) hybrid GaAs:Cr Timepix detector with FitPix interface.

thick pieces. From ^{226}Ra source spectrum the line corresponding to ^{214}Po was used for calibration.

The detector to calibrate was E08-W0153 (figure 2.1 e), and during the measurements it was kept operating with the following parameters: -300 V bias voltage, 16 MHz frequency and $\text{THL} = 180$ DAC.

For experimental data acquisition the PixetPro software version 1.4.4.504 [8] was used.

In order to determine the existing relationship between the energy loss of 5.5 MeV alpha particles crossing Mylar film and this material thickness, the mathematical modeling was used. For these calculations, the SRIM-2013.00 software [9] was applied.

The initial conditions were taken as follows: initial alpha particle energy $E = 5.5$ MeV (^{241}Am source), the particles fall perpendicularly on the target surface, the Mylar mass density was 1.4 g/cm^3 . The Mylar film thicknesses were selected in the interval from $0 \text{ }\mu\text{m}$ up to the value where takes place the total alpha particle absorption, taking specific points matching with the real material thicknesses.

To obtain an adequate statistic, the program was run for 1×10^6 incident alpha particles.

Results

Determining the alphas particles energies

The average energy E' of alpha particles reaching to cross a certain Mylar film thickness d was calculated subtracting the energy loss E_p inside the target, determined by mathematical modeling, to the initial energy (see table 2), taking into account only the ionization losses representing the 99.87% of the total one.

An example of the ion tracks projected in plane obtained from de SRIM simulation, is shown in figure 3.1 a. Observe that a $35 \text{ }\mu\text{m}$ Mylar film thickness is sufficient to the total stopping of the 5.5 MeV alpha particles (red points represent the stopped alpha particles). The in-depth ionization profile produced by alpha particles at same Mylar film thickness can be observed in figure 3.1 b.

Table 2. Relationship of Mylar film thicknesses, mean energy loses within the material and the output alpha particle energies.

$d(\mu\text{m})$	$E_p \text{ (eV)}$	$E' \text{ (keV)}$
0	0	5500
5	573561,86	4930
6	695225,33	4800
10	1197617,39	4300
12	1468092,04	4030
15	1889793,89	3610
18	2355595,83	3140
20	2681925,97	2820
25	3635387,45	1860
26	3857148,18	1640
27	4091930,16	1410
28	4343583,83	1160
29	4614733,34	890
30	4902215,02	600
31	5181823,04	320
32	5401103,36	100

Energy calibration of detector with alpha particles energy calibration with characteristic X-rays

In order to determine the relationship between the energy of the incident alpha particle E and the cluster volume in keV units for selected DAC settings (threshold level (THL) equal to 180 DAC and clock frequency equal to 16 MHz) and bias voltage ($V_{\text{bias}} = -300 \text{ V}$), it was necessary to perform a previous calibration by irradiating the detector with gamma sources. The aim is to find the relationship between the obtained in TOT mode counts and the incident particle energy.

The experimental spectra measured for each X-ray energy were fitted by means of Gaussian function in order to obtain the peak position (see table 1). Only charge induction events occurring in a single pixel were taken into account. For histograms (spectrum) construction

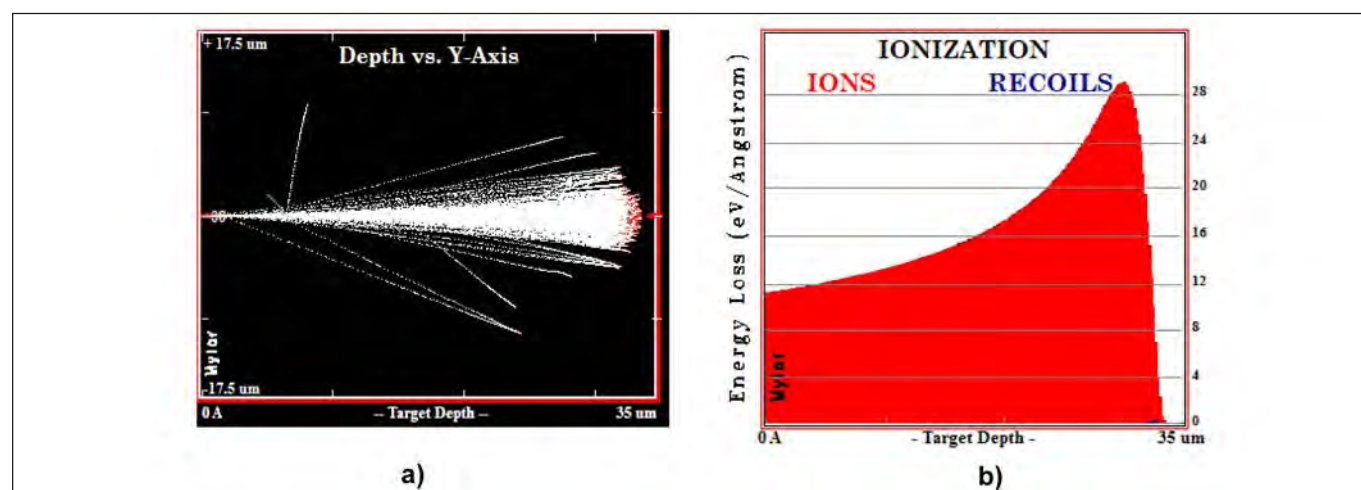


Figure 3.1. a) Representation of ion tracks projected in plane for $35 \text{ }\mu\text{m}$ of Mylar films thicknesses; b) in-depth ionization produced by particles crossing the same Mylar film.

the TOT counts values obtained per pixel was placed in x axis, while in y axis the absolute frequency is indicated.

As example, some spectra obtained from two measurements made at different X-ray energies with the tube at 60 kV and 20 μ A are shown in figure 3.2 (top).

From the calculated and reported in the table 1 data, the dependence of the TOT counts with the incident photon energies was performed. This curve is adjusted by means of the following function [10-11].

$$TOT(E) = a \cdot E + b - \frac{c}{E - t}, \quad (3,2)$$

where a, b, c and t are fit parameters.

Keeping in mind that calibration curves present a region with lineal behavior above the 25 keV, the fitting was carried out in two steps. First, the parameters a and b were calculated using the fluorescence spectra with the higher energy (24.2, 25.27 and 57.54 keV). Second, considering the obtained lineal parameters, the general calibration was carried out to obtain the remaining parameters (c and t), that determine the behavior of the non-linear region below 25 keV [12]. This general calibration was made fixing the obtained previously a and b values with its respective uncertainties in the lineal region. In figure 3.2 (bottom) an example of the two-step energy calibrations is presented.

Finally, to calculate the deposited in the pixel alpha particle energy in eV units, it is necessary to use the inverse of the function (3.2):

$$E(TOT) = \frac{a \cdot t + TOT - b + \sqrt{(b + a \cdot t - TOT)^2 + 4 \cdot a \cdot c}}{2 \cdot a}, \quad (3,3)$$

Energy calibration of detector with alpha particles and experimental verification

The calibration of the Timepix detector for alpha particles is much more complicated than calibration with characteristic X-rays because the total charge can only be revealed by making a summation of all fractional charges, i.e. by determining the cluster volume. Example of cluster volume generated by a single alpha particle is shown in figure 3.3 a.

For the visualization of the alpha cluster peaks in the obtained spectra, it was necessary to perform a simple cluster analysis. Cluster height and cluster size histograms were used to establish limits for cluster volume construction only for alpha cluster selection purposes. Only clusters with heights between 80 and 1700 keV and sizes between 10 and 10000 pixels were selected. Figures 3.3 b and 3.3 c show detector illumination for 5 frames and an alpha cluster for 5.5 MeV energy after alpha cluster selection respectively.

Experimental spectra after alpha cluster selection for each energy were fitted using the Gaussian, thus determining the mean points of each peak and their standard deviations, as shown in figure 3.3 d. For histograms construction, cluster volume values were placed on x axis; while in y axis the absolute frequency with

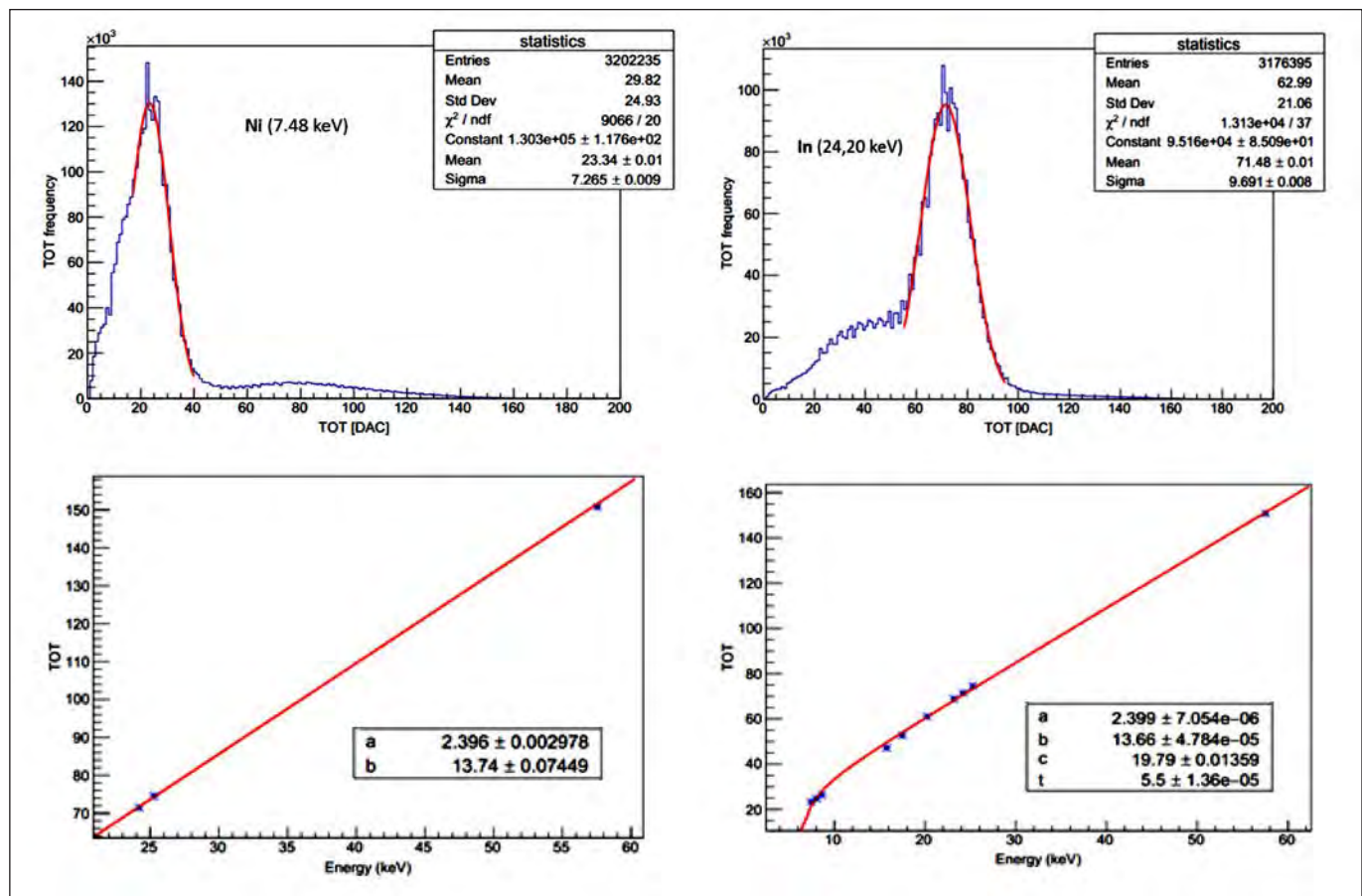


Figure 3.2. Two examples of obtained spectra in TOT mode using selected DAC settings and bias for different X-rays energies (top); carried out two steps energy calibration (bottom): fitting in lineal zone (left) and general fitting (right).

which these values appear. Cluster volume values are expressed in energy unit (keV) because they were translated with equation 3.3.

Taking into account the average values of cluster volume obtained for energy, and energy values corresponding to each peak, the relationship of these magnitudes was established. Finally, the obtained curve was linearly fitted (figure 3.4 a):

$$E'(CV) = p_0 + p_1 \cdot CV \quad (3.4)$$

where p_0 and p_1 are fit parameters.

In order to check the energy calibration, with same detector and under identical conditions was carried out by measuring radon in air. The measurement time was 67 hours.

The ^{218}Po isotope is radon progeny and alpha decays to ^{214}Pb with energy of 6115 keV [13]. This line of radon alpha spectrum was used for experimental verification of the performed calibration. Figure 3.4 b shows spectrum corresponding to this measurement after alpha cluster selection.

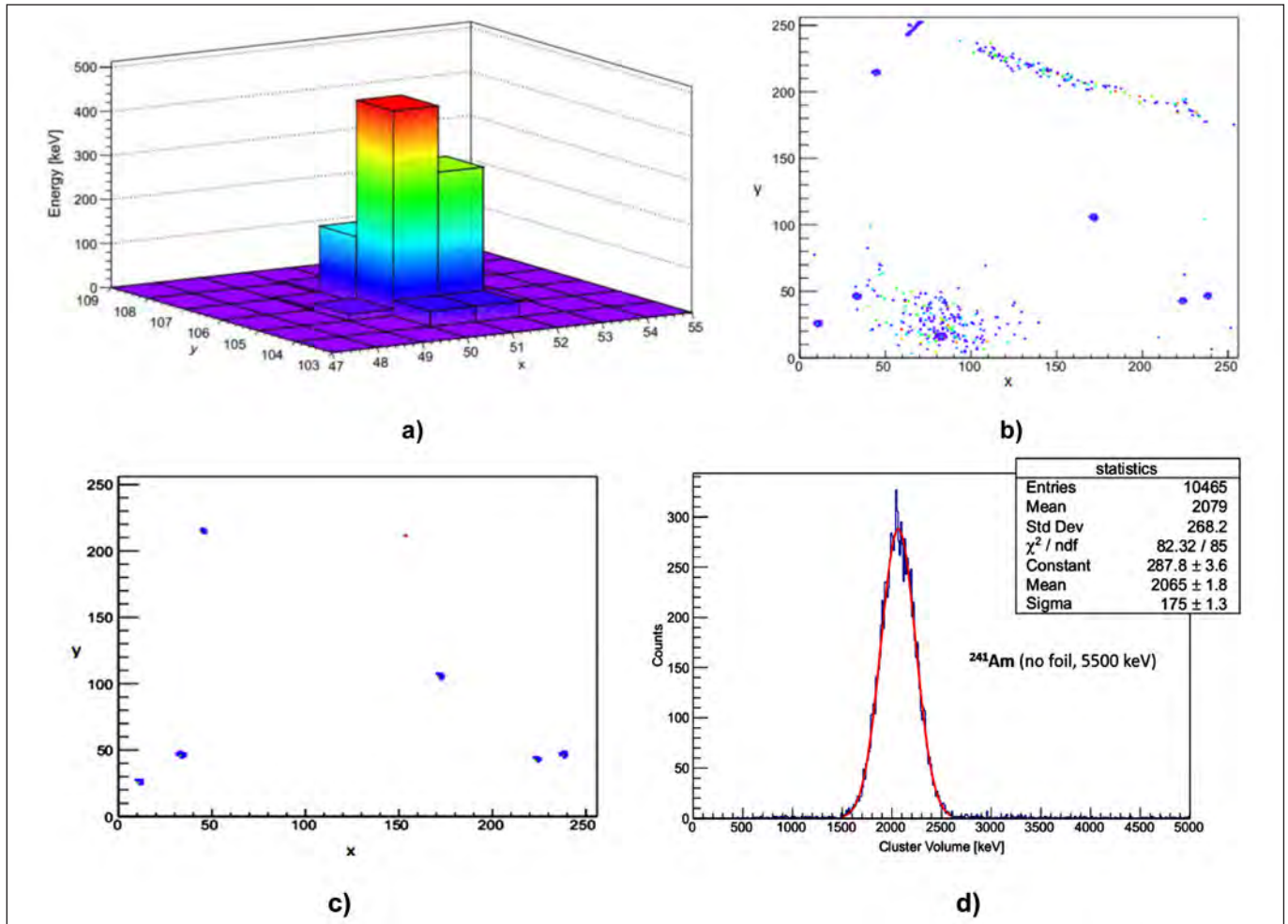


Figure 3.3. a) Pixels cluster generated by single 3140 keV alpha particle; b) detector illumination for 5 frames; and c) alpha cluster for 5.5 MeV alpha particles after cluster selection; d) example of spectra obtained in TOT mode for alpha particles from americium source. x and y axes represent the position in the pixels matrix.

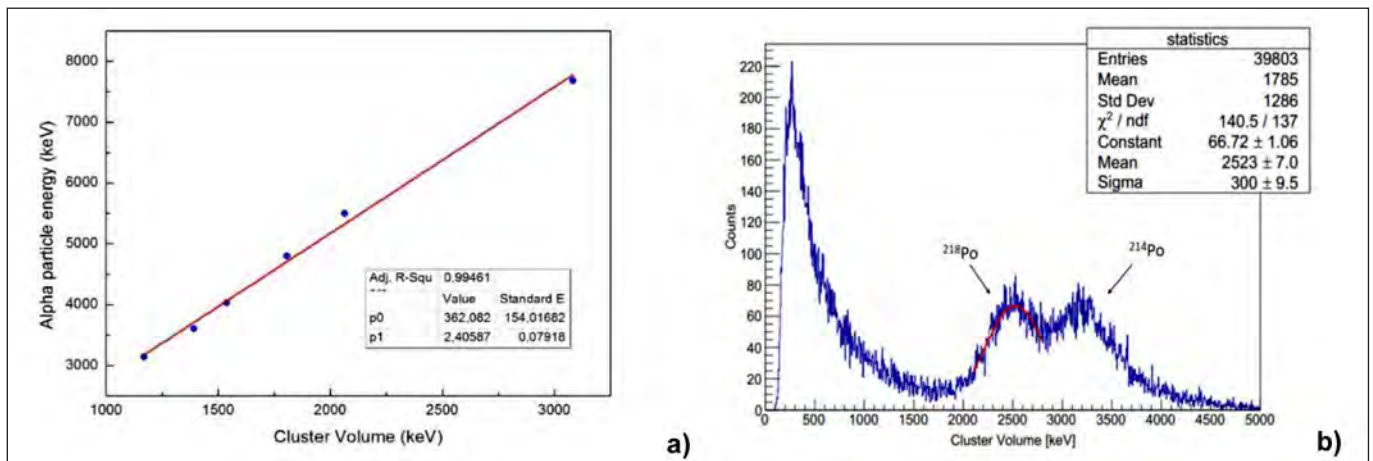


Figure 3.4. a) Energy calibration with alpha particles for selected DAC settings and bias; b) alpha cluster spectrum of radon progenies in air after cluster selection.

The mean value for ^{218}Po peak was calibrated by the function (3.4) to translate cluster volume to incident alpha particles energy, obtaining 6432 ± 370 keV. The value calculated experimentally considering its statistical error corresponds to the reported in literature, concluding that the performed alpha particle energy calibration is acceptable.

Conclusions

The performed mathematical simulation of the 5.5 MeV alpha particles transport through different Mylar film thicknesses, allowed to calculate the transmitted energy making possible the experimental calibration with the use of Mylar as absorbent. It was proved that 35 μm Mylar films thickness is sufficient to the total stop of the alpha particles from a ^{241}Am source.

By calibrating the detector with characteristic X-rays and using a two step fitting procedure, it was determined the relationship between the photon energies and the registered by the detector TOT counts.

The energy calibration with alpha particles was performed according to linear function $y = 362.08 + 2.41 x$, with $R^2 = 0.99$, and was verified with the measurement of the ^{218}Po line of radon in air.

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References

- [1] LLOPART X, BALLABRIGA R, CAMPBELL M, et. al. Timepix, a 65k programmable pixel readout chip for arrival time, energy and/or photon counting measurements. Nucl. Instrum. Methods Phys A. Res. 2007; 581: 485-494.
- [2] AYZENSHTAT GI, BUDNITSKY DL, KORETSKAYA OB, et. al. GaAs resistor structures for X-ray imaging detectors. Nucl. Instrum. Methods Phys A. Res. 2002; 487: 96-101.
- [3] TYAZHEV AV, BUDNITSKY DL, KORETSKAYA OB, et. al. GaAs radiation imaging detectors with an active layer thickness up to 1 mm. Nucl. Instrum. Methods Phys A. Res. 2003; 509: 34-39.
- [4] HAMANN E, CECILIA A, ZWERGER A, et. al. Characterization of photon counting pixel detectors based on semi-insulating GaAs sensor material. J. Phys.: Conf. Ser. 2013; 425: 062015.
- [5] TIKU S & BISWAS D. Integrated circuit fabrication technology. Florida: CRC Press Taylor & Francis Group, 2016. ISBN: 978-981-4669-31-3.
- [6] SHI W & XIE G. Influence of EL2 deep level on photoconduction of semi-insulating GaAs under ultrashort pulse photo injection. Laser Physics Letters. 2016; 13(2): 341- 376.
- [7] SRI. 2016 [consulted on April 10th 2017]. Available in: <http://www.sourceray.com/oem>.
- [8] PixetProSOFTWARE version 1.4.4.504 [consulted on April 12th 2017]. Available in: <http://www.advacam.com/en/products>.
- [9] ZIEGLER JF, ZIEGLER MD & BIERSECK JP. SRIM - The stopping and range of ions in matter. NIM B. 2010; 268(11-12): 1818-1823.
- [10] BUTLER A, BUTLER B, BELL S, et. al. Measurement of the energy resolution and calibration of hybrid pixel detector with GaAs: Cr sensor and Timepix Readout Chip. Physics of Particles and Nuclei Letters. 2015; 12(1): 59-73.
- [11] JAKUBEK J. Precise energy calibration of pixel detector working in time-over-threshold mode. Nuclear Instruments and Methods in Physics Research Section A: Accelerators, Spectrometers, Detectors and Associated Equipment. 2011; 633(1): 262-266.
- [12] BECKHOFF B, KANNGIEBER B, LANGHOFF N, et. al. Handbook of practical X-ray fluorescence analysis. Berlin: Springer, 2006. ISBN: 103-540-28603-9.
- [13] TABLE OF RADIOACTIVE ISOTOPES. 2017 [consulted on May 25th 2017]. Available in: <http://nucleardata.nuclear.lu.se/toi/nuclide.asp?iZA>.

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